

# Search Notes



Application/Control No.

10/695,197

Examiner

Nguyen T. Ha

Applicant(s)/Patent under Reexamination

FUJIYAMA ET AL.

Art Unit

2831

## SEARCHED

Class	Subclass	Date	Examiner
update	Search	6/10/05	NH
361	763	↓	↓
	765		
	766		
	785		
439	70	↓	↓
	71		
	342		
174	252	↓	↓
	255		
	262	6/10/05	NH

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as		6/10/05	NH
above			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fast Search	6/10/05	NH